

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>	ATTY. DOCKET NO.	SERIAL NO.
	107443-00033	New application
	APPLICANT M. SAITOU	
FILING DATE	GROUP	
October 22, 2003	Not Assigned	

U.S. PATENT DOCUMENTS

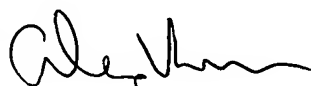
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						

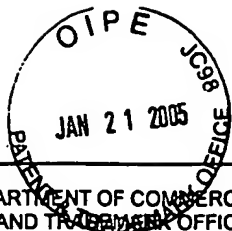
FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.
ATK	AG	2000-353725	12/19/00	Japan					X
ATK	AH	2002-295404	10/9/02	Japan					X
	AI								
	AJ								
	AK								
	AL								
	AL								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	

EXAMINER		DATE CONSIDERED	8/17/03
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			



Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

107443-00033

SERIAL NO.

10/689,696

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

M. SAITOU

FILING DATE

October 22, 2003

GROUP

Unknown

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
ASR	AA	2003/0017350 A1	01/23/03	TAKAI et al.			
↓	AB	3,431,141	03/04/69	J. EORGAN			
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION		
							YES	NO	PART.
ASR	AG	2002/047581	02/15/02	E.P.O.					
↓	AH	1 167 565	01/02/02	E.P.O.					
	AI								
	AJ								
	AK								
	AL								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

ASR	AM	European Search Report
	AN	
	AO	

EXAMINER

DATE CONSIDERED

8/17/05

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